

WEST Search History

DATE: Wednesday, September 10, 2003

Set Name Query

side by side

Hit Count Set Name

result set

DB=USPT; THES=ASSIGNEE; PLUR=YES; OP=OR

L14	L13 and (delay\$4 near2 clos\$4)	11	L14
L13	L12 and (flag or identifier)	1563	L13
L12	L11 and file and cach\$5	1999	L12
L11	open\$4 and clos\$4 and command\$4 and shar\$4	20930	L11
L10	cach with file with open	4	L10
L9	(shar\$4 with violat\$4 with file)	10	L9
L8	(shar\$4 with violat\$4) and casualt\$4	0	L8
L7	((shar\$4 with violat\$4) and casualt\$4)	0	L7
L6	(shar\$4 with violat\$4 with casualt\$4)	0	L6
L5	((shar\$4 with violation) and file and delet\$4 and renam\$5)	5	L5
L4	scavenger adj1 list	3	L4
L3	(cach\$4 with file with open).ab.	5	L3
L2	L1 and (707/\$.ccls.)	22	L2
L1	scavenger	18952	L1

END OF SEARCH HISTORY

WEST Search History

DATE: Wednesday, September 10, 2003

<u>Set Name</u> side by side	<u>Query</u>	<u>Hit Count</u>	<u>Set Name</u> result set
<i>DB=USPT; THES=ASSIGNEE; PLUR=YES; OP=OR</i>			
L2	L1 and (707/\$.ccls.)	22	L2
L1	scavenger	18952	L1

END OF SEARCH HISTORY

Welcome to IEEE Xplore®

- ☐ Home
- ☐ What Can I Access?
- ☐ Log-out

Your search matched **27** of **969893** documents.

A maximum of **27** results are displayed, **15** to a page, sorted by **Relevance** in **descending** order.

You may refine your search by editing the current search expression or entering a new one in the text box.

Tables of Contents

- ☐ Journals & Magazines
- ☐ Conference Proceedings
- ☐ Standards

Then click **Search Again**.

Search

- ☐ By Author
- ☐ Basic
- ☐ Advanced

Results:

Journal or Magazine = **JNL** Conference = **CNF** Standard = **STD**

Member Services

- ☐ Join IEEE
- ☐ Establish IEEE Web Account
- ☐ Access the IEEE Member Digital Library

Badent, R.; Julliard, Y.; Kist, K.; Schwab, A.J.;

Electrical Insulation and Dielectric Phenomena, 2000 Annual Report

Conference on , Volume: 1 , 15-18 Oct. 2000

Page(s): 268 -271 vol.1



[\[Abstract\]](#) [\[PDF Full-Text \(484 KB\)\]](#) **IEEE CNF**

2 Effectors of high temperature reliability in epoxy encapsulated devices

Gallo, A.A.;

Electronic Components and Technology Conference, 1993.

Proceedings., 43rd , 1-4 June 1993

Page(s): 356 -366

[\[Abstract\]](#) [\[PDF Full-Text \(492 KB\)\]](#) **IEEE CNF**

3 Development of conductive adhesives for solder replacement

Daoqiang Lu; Wong, C.P.;

Components and Packaging Technologies, IEEE Transactions on [see also Components, Packaging and Manufacturing Technology, Part A: Packaging Technologies, IEEE Transactions on] , Volume: 23 Issue: 4 , Dec. 2000

Page(s): 620 -626

[\[Abstract\]](#) [\[PDF Full-Text \(124 KB\)\]](#) **IEEE JNL**

**IEEE Xplore®**
RELEASE 1.5Welcome
United States Patent and Trademark Office[Help](#) [FAQ](#) [Terms](#) [IEEE](#) [Quick Links](#)[» Search Results](#)

Welcome to IEEE Xplore®

Your search matched **[0]** of **[969893]** documents.

- ☐ Home
- ☐ What Can I Access?
- ☐ Log-out

Tables of Contents

- ☐ Journals & Magazines
- ☐ Conference Proceedings
- ☐ Standards

Search

- ☐ By Author
- ☐ Basic
- ☐ Advanced

Member Services

- ☐ Join IEEE
- ☐ Establish IEEE Web Account
- ☐ Access the IEEE Member Digital Library

Print Format

You may refine your search by editing the current search expression or entering a new one the text box. Then click search Again.

OR

Use your browser's back button to return to your original search page.

Results:**No documents matched your query.**

[Home](#) | [Log-out](#) | [Journals](#) | [Conference Proceedings](#) | [Standards](#) | [Search by Author](#) | [Basic Search](#) | [Advanced Search](#)
[Join IEEE](#) | [Web Account](#) | [New this week](#) | [OPAC Linking Information](#) | [Your Feedback](#) | [Technical Support](#) | [Email Alerting](#)
[No Robots Please](#) | [Release Notes](#) | [IEEE Online Publications](#) | [Help](#) | [FAQ](#) | [Terms](#) | [Back to Top](#)

[IEEE HOME](#) | [SEARCH IEEE](#) | [SHOP](#) | [WEB ACCOUNT](#) | [CONTACT IEEE](#)[Membership](#) | [Publications/Services](#) | [Standards](#) | [Conferences](#) | [Careers/Jobs](#)**IEEE Xplore®**
RELEASE 1.5Welcome
United States Patent and Trademark Office[Help](#) | [FAQ](#) | [Terms](#) | [IEEE](#) | [Quick Links](#)[» Search Results](#)[Peer Review](#)

Welcome to IEEE Xplore®

Your search matched **[0]** of **[969893]** documents.

- ☐ Home
- ☐ What Can I Access?
- ☐ Log-out

Tables of Contents

- ☐ Journals & Magazines
- ☐ Conference Proceedings
- ☐ Standards

Search

- ☐ By Author
- ☐ Basic
- ☐ Advanced

Member Services

- ☐ Join IEEE
- ☐ Establish IEEE Web Account
- ☐ Access the IEEE Member Digital Library

Print Format

You may refine your search by editing the current search expression or entering a new one the text box. Then click search Again.

OR

Use your browser's back button to return to your original search page.

Results:**No documents matched your query.**

[Home](#) | [Log-out](#) | [Journals](#) | [Conference Proceedings](#) | [Standards](#) | [Search by Author](#) | [Basic Search](#) | [Advanced Search](#)
[Join IEEE](#) | [Web Account](#) | [New this week](#) | [OPAC Linking Information](#) | [Your Feedback](#) | [Technical Support](#) | [Email Alerting](#)
[No Robots Please](#) | [Release Notes](#) | [IEEE Online Publications](#) | [Help](#) | [FAQ](#) | [Terms](#) | [Back to Top](#)

Copyright © 2003 IEEE — All rights reserved

Welcome to IEEE Xplore®

- ☐ Home
- ☐ What Can I Access?
- ☐ Log-out

Tables of Contents

- ☐ Journals & Magazines
- ☐ Conference Proceedings
- ☐ Standards

Search

- ☐ By Author
- ☐ Basic
- ☐ Advanced

Member Services

- ☐ Join IEEE
- ☐ Establish IEEE Web Account
- ☐ Access the IEEE Member Digital Library

 Print FormatYour search matched **56** of **969893** documents.A maximum of **56** results are displayed, **25** to a page, sorted by **Relevance** in **descending** order.

You may refine your search by editing the current search expression or entering a new one in the text box.

Then click **Search Again**.

delete <and> file

[Search Again](#)**Results:**Journal or Magazine = **JNL** Conference = **CNF** Standard = **STD****1 Adding availability to log services of untrusted machines***Arona, A.; Bruschi, D.; Rosti, E.;*

Computer Security Applications Conference, 1999. (ACSAC '99)

Proceedings. 15th Annual , 6-10 Dec. 1999

Page(s): 199 -206

[\[Abstract\]](#) [\[PDF Full-Text \(116 KB\)\]](#) **IEEE CNF****2 Modeling and dimensioning hierarchical storage systems for low-delay video services***Chan, S.-H.G.; Tobagi, F.A.;*

Computers, IEEE Transactions on , Volume: 52 Issue: 7 , July 2003

Page(s): 907 -919

[\[Abstract\]](#) [\[PDF Full-Text \(1314 KB\)\]](#) **IEEE JNL****3 Supporting insertions and deletions in striped parallel filesystems***Johnson, T.;*

Parallel Processing Symposium, 1993., Proceedings of Seventh

International , 13-16 April 1993

Page(s): 425 -433

[\[Abstract\]](#) [\[PDF Full-Text \(680 KB\)\]](#) **IEEE CNF****4 Highly reliable on-line partial file modification for office data provisioning in "NOSES";***Matsumura, H.; Sunaga, H.; Koyanagi, K.; Kasuga, S.;*